



Advantages of Laser Repairable Chip On Board

- Non-contact rework.
- Ambient temperature rework. Assemblies do not have to heated to loosen die attach epoxy.
- Rework at very high part density.
- Higher reliability of reworked site

Description of the Designs - Version 1

• Version 1:

- Four layers of flex laminated to rigid board.
- Four die attach layers (three repairs possible).
- Two GND/PWR planes.
- All layers are polyimide.
- Vias are through hole punches.
- No buried vias.
- Trace spacing is min 25 mils.
- Nine sites (NAND Gates)

COB Diagram







Second Generation FR4 Rigid Laser Repairable Chip-on-Board

	 Top layer H/0 GFN UV board GE no flow prepreg A11 1080 Inner layer1 H/0 GFN UV board GE no flow prepreg A11 1080 Inner layer2 H/0 GFN UV board GE prepreg A11 1080 Inner layer3 H/0 GFN UV board GE prepreg A11 1080 Inner layer4 H/0 GFN UV board GE prepreg A11 1080 	0.005" 0.003" 0.005" 0.003" 0.005" 0.003" 0.005" 0.003"
	 GE prepreg A11 1080 GND/VCC layer H/H GFN UV board 1 mil adhesive/1 mil kapton LF0110 	0.003" 0.005" 0.002"

Total 0.047"

Applications -High Density, 3D Multi-Chip Modules



Future Plans

- Qualification for Space Environment
- Packaging option for in-house 600/900 instruments
- Extend to higher density packaging designs and additional applications (microwave, high power, etc.)

Visual Inspection

• Version 1:

- bowing: 1% to 3% (1% or less is required for good die attach)
- good gold coverage in die attach and wire bond sites
- some excess polyimide in die attach and wire bond site
- ample length on wire bond "fingers"
- registration between repairable layers between
 5% and 30% off
- electrically correct and no opens/shorts



Die Attach

- Version 1:
 - Cleanliness an issue. Requires plasma cleaning and care in handling and storage to maintain cleanliness.
 - Shear Strength (pass > 0.7 kg):
- on "as-delivered" board: 1.0kg to 1.85 kg
- on temperature, vacuum, laser processed conditioned board: TBD
- Version 2: TBD

Wire Bond

• Version 1: (pass > 3.0 g)

"as-delivered" boards were difficult to wirebond due to the lack of rigidness at the bond site. Heated stage exacerbated this problem. Bond pull data shows improved process with experience, though still not acceptable.













Remaining Work and Future Opportunities

- Die Shear and Bond Pull for Version I
- Analysis of ability to make good bonds to this surface
- Analysis of conditioning on die attach and wire bond strength
- Die attach and wire pull for Version II
- Conditioning Version II
- Laser and hand rework of Version II
- Die attach and wire pull Version II